

Search Notes

Application/Control No.

10/762,934

Examiner

Paul R. Myers

Applicant(s)/Patent under
Reexamination

CHEN, BEN WEI

Art Unit

2111

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East searched see attached	1/30/2007	PRM